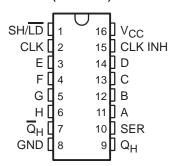
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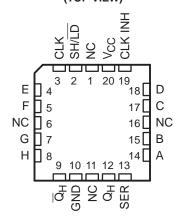
- Wide Operating Voltage Range of 2 V to 6 V
- Outputs Can Drive Up To 10 LSTTL Loads
- Low Power Consumption, 80-μA Max I_{CC}
- Typical t_{pd} = 13 ns
- ±4-mA Output Drive at 5 V

SN54HC165 . . . J OR W PACKAGE SN74HC165 . . . D, DB, N, NS, OR PW PACKAGE (TOP VIEW)



- Low Input Current of 1 μA Max
- Complementary Outputs
- Direct Overriding Load (Data) Inputs
- Gated Clock Inputs
- Parallel-to-Serial Data Conversion

SN54HC165 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

description/ordering information

The 'HC165 devices are 8-bit parallel-load shift registers that, when clocked, shift the data toward a serial (Q_H) output. Parallel-in access to each stage is provided by eight individual direct data (A–H) inputs that are enabled by a low level at the shift/load (SH/\overline{LD}) input. The 'HC165 devices also feature a clock-inhibit (CLK INH) function and a complementary serial (\overline{Q}_H) output.

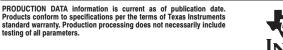
ORDERING INFORMATION

TA	PACKA	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – N	Tube of 25	SN74HC165N	SN74HC165N
		Tube of 40	SN74HC165D	
	SOIC - D	Reel of 2500	SN74HC165DR	HC165
		Reel of 250	SN74HC165DT	
-40°C to 85°C	SOP - NS	Reel of 2000	SN74HC165NSR	HC165
	SSOP - DB	Reel of 2000	SN74HC165DBR	HC165
		Tube of 90	SN74HC165PW	
	TSSOP - PW	Reel of 2000	SN74HC165PWR	HC165
		Reel of 250	SN74HC165PWT	
	CDIP – J	Tube of 25	SNJ54HC165J	SNJ54HC165J
-55°C to 125°C	CFP – W	Tube of 150	SNJ54HC165W	SNJ54HC165W
	LCCC – FK	Tube of 55	SNJ54HC165FK	SNJ54HC165FK

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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description/ordering information (continued)

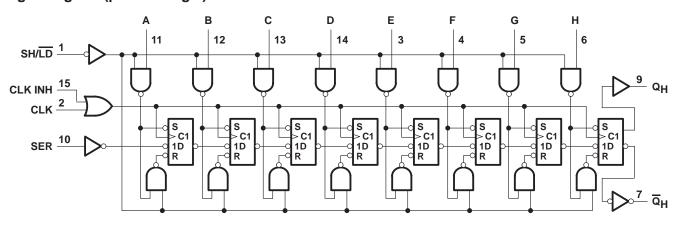
Clocking is accomplished by a low-to-high transition of the clock (CLK) input while SH/\overline{LD} is held high and CLK INH is held low. The functions of CLK and CLK INH are interchangeable. Since a low CLK and a low-to-high transition of CLK INH also accomplish clocking, CLK INH should be changed to the high level only while CLK is high. Parallel loading is inhibited when SH/\overline{LD} is held high. While SH/\overline{LD} is low, the parallel inputs to the register are enabled independently of the levels of the CLK, CLK INH, or serial (SER) inputs.

FUNCTION TABLE

SH/LD	CLK	CLK INH	FUNCTION
L	Χ	Χ	Parallel load
Н	Н	Χ	No change
Н	Χ	Н	No change
Н	L	\uparrow	Shift [†]
Н	\uparrow	L	Shift [†]

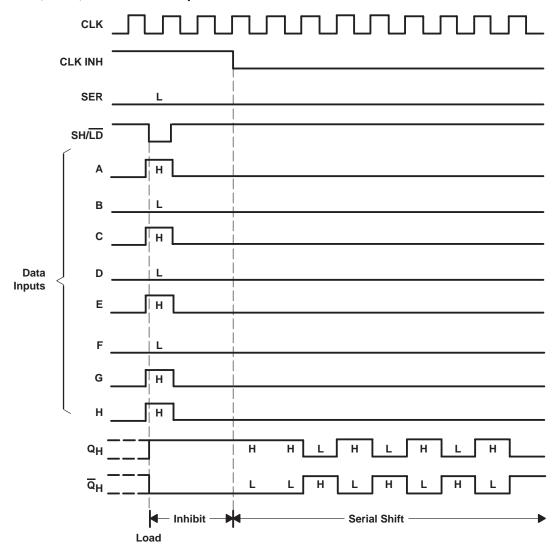
[†] Shift = content of each internal register shifts toward serial output Q_H. Data at SER is shifted into the first register.

logic diagram (positive logic)



Pin numbers shown are for the D, DB, J, N, NS, PW, and W packages.

typical shift, load, and inhibit sequence



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}		0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (se	ee Note 1)	±20 mA
Output clamp current, IOK (VO < 0 or VO > VCO	c) (see Note 1)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})		
Continuous current through V _{CC} or GND		±50 mA
Package thermal impedance, θ_{JA} (see Note 2):	D package	73°C/W
	DB package	82°C/W
	N package	67°C/W
	NS package	64°C/W
	PW package	108°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

			SI	N54HC16	35	SN74HC165		5		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage		2	5	6	2	5	6	V	
		V _{CC} = 2 V	1.5			1.5				
VIH	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V	
		VCC = 6 V	4.2			4.2				
		V _{CC} = 2 V			0.5			0.5	V	
٧ _{IL}	Low-level input voltage	V _{CC} = 4.5 V			1.35			1.35		
		V _{CC} = 6 V			1.8			1.8		
٧ _I	Input voltage		0		VCC	0		VCC	V	
VO	Output voltage		0		VCC	0		VCC	V	
		V _{CC} = 2 V			1000			1000		
Δt/Δv‡	Input transition rise/fall time	V _{CC} = 4.5 V			500			500	ns	
		V _{CC} = 6 V			400			400		
TA	Operating free-air temperature		-55		125	-40		85	°C	

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.

[‡] If this device is used in the threshold region (from V_{IL}max = 0.5 V to V_{IH}min = 1.5 V), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at t_t = 1000 ns and V_{CC} = 2 V does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

242445	TEST CONDITIONS		.,	Т	A = 25°C	;	SN54H	IC165	SN74H	C165	
PARAMETER	IESI CC	ONDITIONS	vcc	VCC MIN		MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
		$I_{OH} = -20 \mu A$	4.5 V	4.4	4.499		4.4		4.4		
∨он	VI = VIH or VIL		6 V	5.9	5.999		5.9		5.9		V
		$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		$I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.2		5.34		
		I _{OL} = 20 μA	2 V		0.002	0.1		0.1		0.1	
			4.5 V		0.001	0.1		0.1		0.1	
VoL	VI = ∧IH or ∧IΓ		6 V		0.001	0.1		0.1		0.1	V
		I _{OL} = 4 mA	4.5 V		0.17	0.26		0.4		0.33	
	$I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.4		0.33		
lį	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA
Icc	$V_I = V_{CC}$ or 0,	IO = 0	6 V			8		160		80	μΑ
Ci		·	2 V to 6 V		3	10		10		10	pF

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timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			.,	T _A = 2	25°C	SN54F	IC165	SN74H	C165	
			VCC	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		6		4.2		5	
fclock	Clock frequency		4.5 V		31		21		25	MHz
			6 V		36		25		29	
	t _W Pulse duration CLK high or low		2 V	80		120		100		
		SH/LD low	4.5 V	16		24		20		
			6 V	14		20		17		
ιW			2 V	80		120		100		ns
		CLK high or low	4.5 V	16		24		20		
			6 V	14		20		17		
			2 V	80		120		100		
		SH/LD high before CLK↑	4.5 V	16		24		20		
			6 V	14		20		17		
			2 V	40		60		50		
		SER before CLK↑	4.5 V	8		12		10		
			6 V	7		10		9		
			2 V	100		150		125		ns
t _{su}	Setup time	CLK INH low before CLK↑	4.5 V	20		30		25		
	t _{Su} Setup time CLK INH low before CLK↑		6 V	17		25		21		
			2 V	40		60		50		
		CLK INH high before CLK↑	4.5 V	8		12		10		
			6 V	7		10		9		
			2 V	100		150		125		
		Data before SH/ LD ↓	4.5 V	20		30		25		
			6 V	17		26		21		
			2 V	5		5		5		
		SER data after CLK↑	4.5 V	5		5		5		
4.	I laid time		6 V	5		5		5		-
th	Hold time		2 V	5		5		5		ns
		PAR data after SH/LD↓	4.5 V	5		5		5		
			6 V	5		5		5		

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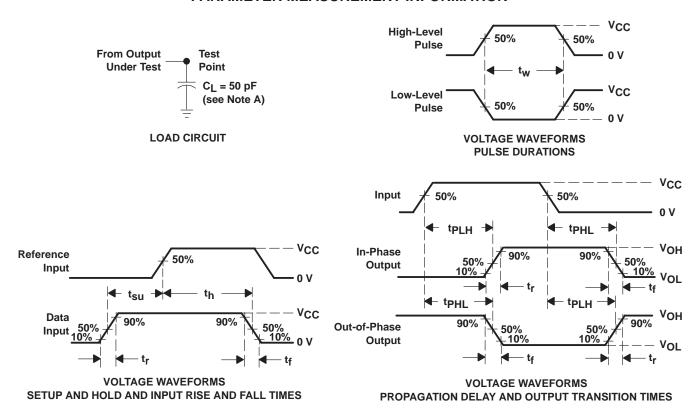
switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

24244555	FROM	то	l ,,	T,	ղ = 25°C	;	SN54H	IC165	SN74H	C165	
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	6	13		4.2		5		
fmax			4.5 V	31	50		21		25		MHz
			6 V	36	62		25		29		
			2 V		80	150		225		190	
	SH/LD	Q _H or $\overline{\mathbb{Q}}_{H}$	4.5 V		20	30		45		38	
			6 V		16	26		38		32	
	CLK	Q _H or \overline{Q}_{H}	2 V		75	150		225		190	
^t pd			4.5 V		15	30		45		38	ns
			6 V		13	26		38		32	
	Н		2 V		75	150		225		190	
		Q _H or $\overline{\mathbb{Q}}_{H}$	4.5 V		15	30		45		38	
			6 V		13	26		38		32	
			2 V	·	38	75		110		95	
t _t	Any	Any	4.5 V		8	15		22		19	ns
		6 V		6	13		19		16		

operating characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	No load	75	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f = 6 \ ns$, $t_f = 6 \ ns$.
- C. For clock inputs, f_{max} is measured when the input duty cycle is 50%.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



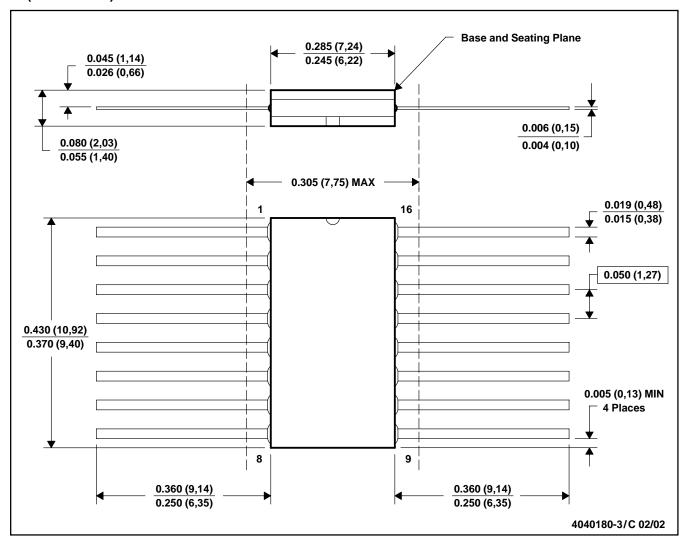
14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

W (R-GDFP-F16)

CERAMIC DUAL FLATPACK



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP-1F16 and JEDEC MO-092AC

FK (S-CQCC-N**)

28 TERMINAL SHOWN

LEADLESS CERAMIC CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

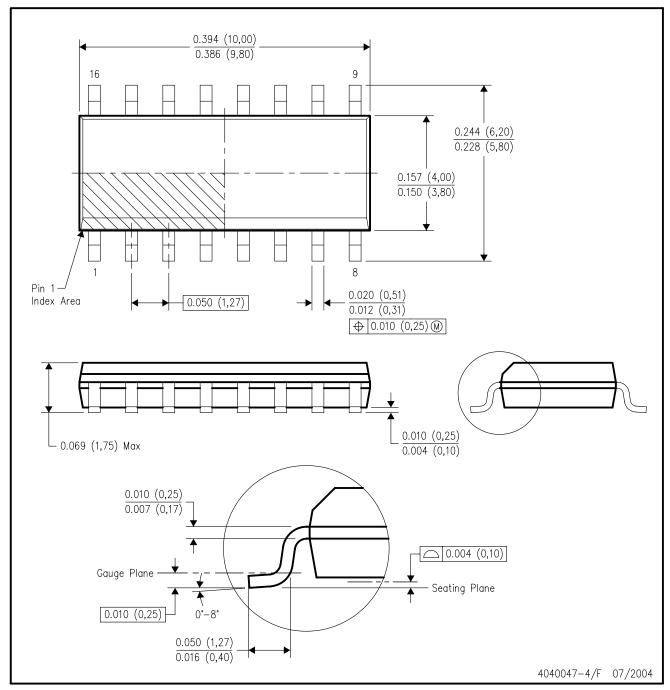


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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